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III. Accurate Determination of Optical Properties: Overlayer EffectsIV. Living with Overlayers; V. Eliminating Overlayers; VI. Bulk and Thin-Film Effects; Effective-Medium Theory; VII. Conclusion; References; References; Chapter 6. Interferometric Methods for the Determination of Thin-Film Parameters; I. Introduction; II. Basic Principles; III. Nonlaser Interferometers; IV. Kosters-Prism Interferometers; V. A Self-Calibrating Method; VI. Surface Effects; VII. Conclusions; References; Chapter 7. Thin-Film Absorptance Measurements Using Laser Calorimetry; I. Introduction
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Sommario/riassunto

While bits and pieces of the index of refraction n and extinction coefficient k for a given material can be found in several handbooks, the Handbook of Optical Constants of Solids gives for the first time a single set of n and k values over the broadest spectral range (ideally from x-ray to mm-wave region). The critiquers have chosen the numbers for you, based on their own broad experience in the study of optical properties. Whether you need one number at one wavelength or many numbers at many wavelengths, what is available in the literature is condensed down